Search Notes			

Application/Control N	Applicant(s)/Patent under Reexamination	•
10/709,198	LIN ET AL.	
Examiner	Art Unit	
Linh V. Nguyen	2819	

SEARCHED			
Class	Subclass	Date	Examiner
330	254	11/4/2005	LN
······································			

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
·			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
see search print out	11/4/2005	LN	
	•		